

**Search Notes**

Application/Control No.

10/598,685

Examiner

HIEU T. VO

Applicant(s)/Patent under  
Reexamination

ISHII ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	445 472 585 188.4	9/16/2007	VH
180	219 229	9/16/2007	VH
180	68.1 68.4	9/16/2007	VH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
All of above		9/16/2007	VH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/16/2007	VH